PTO/SB/08B (04-03)
Approved for use through 04/30/2003. OMB 0651-0031
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE
Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449/PTO

Sheet

PFORMATION DISCLOSURE

TATEMENT BY APPLICANT

(Use as many sheets as necessary)

of

Complete if Known				
Application Number	10/776,214			
Filing Date	12 February 2004			
First Named Inventor	Isaak D. Mayergoyz			
Art Unit	3651			
Examiner Name	unknown			
Attorney Docket Number	MR2833-35			

			NON PATENT LITERATURE DOCUMENTS		
Examiner Initials*					
X0	M	A	C. Tse, et al., "High-speed massive imaging of hard disk data by using the spin-stand imaging technique," J. Appl. Psys., Vol. 93, No. 10, pgs. 6578 – 6580, 15 May 2003		
		В	I.D. Mayergoyz, et al., "Scaling of head response function in the spin-stand imaging technique," J. Appl. Phys., Vol. 93, No. 10, Pgs 6581-6583, 15 May 2003.		
	I.D. Mayergoyz, et al., "Extraction of the response function of GMR head for spin stand imaging," IEEE. Trans. Magn., Vol. 38, No. 5, pgs 2453-2455, 5 Sept. 2002				
		D	C. Tse, et al., "Spatial and vectorial characterization of thermal relaxation using the spin- stand imaging technique." J. Appl. Psys., Vol. 91, No. 10, pgs. 8846-8848, 15 May 2002		
		E	I.D. Mayergoyz, et al., "Spin-stand imaging of overwritten data and its comparison with magnetic force microscopy," J. Appl. Phys., Vol. 89, No. 11, pgs. 6772-6774, 1 June 2001		
		F	I.D. Mayergoyz, et al., "Spin-stand imaging of transverse magnetization profiles of recorded tracks," J. Appl. Phys, Vol. 89, No. 11, pgs. 6775-6777, 1 June 2001		
		G	C. Tse, et al., "Spin-stand study of data-dependent thermal relaxations of magnetization patterns," J. Materials Processing & Manufacturing Science, Vol. 9, pgs. 82-89, Oct. 2000		
		н	I. D. Mayergoyz, et al., "Magnetic imaging on a spin-stand," J. Appl. Phys., Vol. 87, No. 9, pgs. 6824-6826, 1 May 2000		
	<u> </u>	i .	I.A. Beardsley, "Reconstruction of the Magenetization in a Thin Film by a Combination of Lorentz Microscopy and External Field Measurements," IEEE Trans. Magn., Vol. 25, No. 1, pgs. 671-677, Jan 1989		
001	M	J	I.D. Mayergoyz, et al., "Magnetization Image Reconstruction from Magnetic Force Scanning Microscopy Images," J. Appl. Phys., Vol. 73, No. 10, pgs, 5799-5801, 15 May 1993		

	<u> </u>		
Examiner	200	Date	4/00 /00
Signature		Considered	1/0/105

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37 CFR 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 120 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark-Office, U.S. Department of Commerce, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, Washington, DC 20231.